

Tantalum Chip Capacitors

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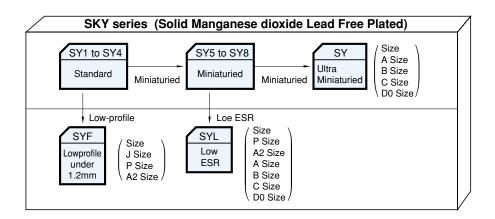




■Type list for tantalum Electrolytic capacitors

Series name	SKY (Solid Manganese dioxide Lead-Free Plated)						
Processed style		Resin molded chip type					
Type designation	SYF	SYL					
Photograph	* *		86				
Features	Lowprofile Hight:1.2mm	Standard , Miniaturied & Ultra Miniaturied	Low ESR				
Applicable standard		JISC5101-3:1998(IEC60384-3:1989)					
Category temperature range(°C)		-55 to +125°C (Above 85°C use category voltage)					
Rated voltage(VDC)	2.5 to 25	2.5 to 35	4 to16				
Rated capacitance(µF)	0.1 to 47 0.1 to 470		1 to 330				
Rated capacitance tolerance(%)	±10%, ±20% (However SY9, SYF-J only ±20%)						
Leakage current(µA)		0.01CV(5 min) or less (SK9: 0.1CV(5 min) or less)					

■Systematized classification





■ Caution for using tantalum chip capacitor. (Refer also to the TECHNICAL NOTE)

Please read product specifications before using ELNA products

■ Circuit design

1. Confirm rated performances.

Confirm the working and installation environments of the set, and use the set within the range of specified rated performances.

Since a failure rate has been provided, set your circuit according to the failure rate. The failure rate can be reduced by decreasing the working voltage, working temperature, or limiting rush current by inserting a resistance, and the like.

2. Use the set within rated voltage.

Rated voltage is defined as a maximum peak voltage (the sum of DCV and peak ACV) that can be applied to a capacitor at a maximum working temperature.

Use the set at voltages within the rated voltage. At temperatures more than 85°C, use the set at voltages not more than the derated voltage.

It is recommended to derate working temperature as far as reliability allows.

When the set is used in a low impedance circuit, voltage should not be more than or one third of the recommended rated voltage.

3. Use the set at temperatures within the category temperature range.

At temperatures more than 85°C, apply a voltage not more than the derated voltage. Low temperature usage is advantageous for reliability. If capacitors make self-heat generation by application of ripples or other reasons, take such a temperature rise into consideration.

4. Pay attention to an excessive momentary current.

Since the set's usage in a low-impedance circuit, such as a power circuit, is likely to raise the failure rate. Please be careful about the following matters:

- (1) If the power supply side impedance looking from the capacitor side is low when voltage is applied, a momentary current will likely cause a short circuit or an increased leakage current.
 - Therefore, insert a resistance of $3\Omega/V$ or higher.
- (2) The use of a fully derated voltage (one third of the rated voltage or lower) is recommended to control rush current and to lower the failure rate.

5. Pay attention to ripple current.

The ripple capability of the tantalum chip capacitor is determined by heat loss of the capacitor element and the heat radiation coefficient of its package case.

When the allowable value is exceeded, the self-heat-generation of the capacitor increases to cause trouble. This must be given much attention.

The sum of the peak DCV value and ripple voltage must not exceed the rated value. Set the DCV so that the peak value does not become a reverse voltage.

6. Do not apply a reverse voltage.

Since the tantalum chip capacitor has polarity, do not apply a reverse voltage to the part. Applying voltage with reversed polarity could cause an abnormal current to damage the capacitor.

When ripple voltage is applied, control it not to exceed the allowable value.

7. Pay attention to frequency characteristics.

Capacitance and tangent of loss angle of tantalum chip capacitors are usually measured at 120Hz.

Increased frequency decreases capacitance and raises tangent of loss angle, which must be given attention in designing.

Tantalum chip capacitors are different from film and ceramic capacitors in characteristics.

Be careful when a tantalum capacitor is used as an alternative.

Mounting

- 1. In mounting, confirm the rated voltage, capacitance, and polarity before usage.
- 2. Don't cut off the materials of the capacitor due to the mounting space and other reasons.
- 3. Don't apply an excessive force to the capacitor.
- 4. Do not use the capacitor that has fallen once on the floor.
- 5. Do not remove and reuse the capacitor that has been mounted once.
- Connect the capacitors to a tester or multimeter carefully. Avoid applying overvoltage or reverse voltage to the capacitors.



■ Caution for using tantalum chip capacitor. (Refer also to the TECHNICAL NOTE)

Please read product specifications before using ELNA products

Soldering

1. Be sure to observe the soldering conditions stipulated in our catalogs and specifications.

It is very important in terms of reliability that soldering is completed in the shortest possible time and under conditions where the joints will be soldered perfectly.

- 2. Wash products immediately after the soldering process so that the dregs of flux and the remaining acid and alkali will not be left.
- 3. Avoid the use of ultrasonic cleaning whenever possible.

If the use of ultrasonic cleaning is unavoidable, make a trial of the system in conditions severer than those in actual cleaning to check for any abnormality.

4. Melting point of terminal plating(Sn 100%) is 232°C. If the soldering of lead free at 232°C or less, confirm the presence of abnormality enough.

(For the reflow method, soldering from the peak temperature 235°C to 250°C is recommended.)

■ In a emergency

1. Do not touch a capacitor directly when the set is being used, it could cause an electric shock.

Never place conductive solutions, such as acid and alkali, on the capacitor. Those solutions could cause a short circuit between circuits or in the capacitor.

- 2. If a strange smell or smoke is generated from a set in use, turn off the main power supply for the set immediately.
- 3. If a capacitor burns, combustion and decomposition gases are generated from the wold resin and the like. Therefore, do not get close to the capacitor.

Storage

1. Keep the products clean at room temperatures (not more than 40°C) and relative humidities (not more than 70°C).

Leaving them at high temperatures and humidities reduces their solderability significantly. Storage in packaged condition is recommended.

- 2. Keep the product out of direct sun exposure.
- 3. Store products in a manner that does not apply unnecessary external force.
- 4. Avoid storage in an area where vibration exists.
- 5. Fumigation treatment with toxic gas covering the whole wooden container frames as moth proofing during shipment may leave residual toxic gas.

6. Storage for a long period of time deteriorates packaging materials.

Pay attention to taping materials in particular, since they deteriorate easily.

It is recommended to use the capacitor within one year.

■ Transportation

Do not drop the products on the floor or on a table.

Since these products use solidified tantalum powder, handle the capacitors carefully because excessive vibration or shock will likely cause reliability reduction.

Disposal

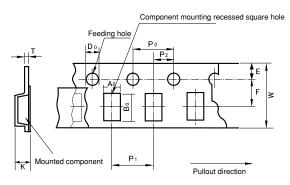
If any capacitors need to be disposed, treat as industrial waste.

Other notes

- 1. In addition to the above-mentioned matters, be sure to confirm the contents of the following document; Technical report of Japan Electronics and Information Technology Industries Association, EIAJ RCR-2368B, the "Guideline of notabilia for fixed tantalum electrolytic capacitors with solid electrolyte for use in electronic equipment"
- 2. Please understand beforehand that the contents of our catalogs are subject to alteration for improvement without prior notice.

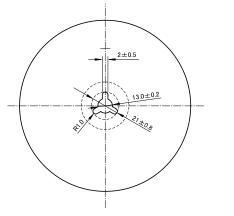
Data mentioned in our catalog are representative values that do not assure performances.

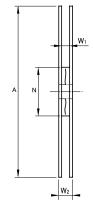
■Emboss carrier tape dimension



_											ι	nıt: mm
	Size code	Ao±0.2	Bo±0.2	K±0.2	W±0.3 Tape width	F±0.1	P1±0.1 Pitch of component	E±0.1	P2±0.1	Pı±0.1 Feed hole pitch	Do +0.1 Feed hole diameter	T
ſ	J	1.0	1.8	1.1								
ſ	P	1.4	2.2	1.2								
ſ	A2	1.9	3.5	1.25	8.0	3.5	4					0.2
	A	1.9	3.5	1.9				1.75	2.0	4.0	1.5	l
ſ	В	3.1	3.8	2.1								0.3
	С	3.7	6.4	2.9	12.0	5.5	8					
	D0	4.8	7.7	3.2	12.0	5.7	0					

■Taping reel dimension





					Unit: mm
Size code	Tape width	A±2.0	N (Min.)	W2±1.0	W1±0.3
J, P, A2, A, B	8	180	60	11.4	9
C, D0	12	180	60	15.4	13

*Recycling Reels might be used for the resource conservation.

■Packaging quantity

Size code	Quantity / Reel
J	4,000 pcs.
P, A2	3,000 pcs.
A, B	2,000 pcs.
C, D0	500 pcs.

■Sealing tape reel strength

Peel angle: 165 to 180° referred to the surface on which the tape $\,$

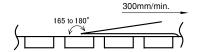
is glued.

Peel speed: 300mm per minute.

The peel strength must be 0.1 to 0.7N under these conditions.

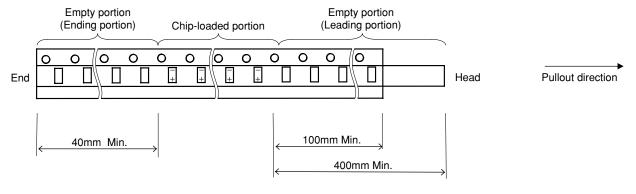
■Component insersion on reel

It is required that the number of empty places in the tape par reel shall not exceed 0.1% without consecutive empty places.



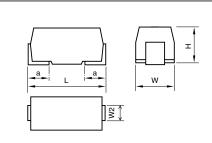
■Packing method

- Polarity: Anode on the opposite side of the feed hole. (for the polarity code R only.) The bottom of lead is toward the emboss pocket. upper marking side is faced to the top cover tape.
- The leader length of the tape shall not be less than 400mm including 10mm or more embossed sections in which no parts are contained.
- The winding core is provided with an over 40mm long empty section.





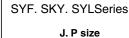
Outside dimensions

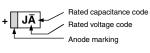


EIA code	Size code	L±0.1	W±0.1	H±0.1	W2±0.1	a±0.15
1608	J	1.6	0.8	0.8	0.6	0.3

EIA code	Size code	L±0.2	W±0.2	H±0.2	W2±0.2	a±0.3
2012	P	2.0	1.25	1.2(max.)	0.9	0.5
3216L	A2	3.2	1.6	1.2(max.)	1.2	0.8
3216	A	3.2	1.6	1.6	1.2	0.8
3528	В	3.4	2.8	1.9	2.2	0.8
6032	С	6.0	3.2	2.5	2.2	1.3
7343	D0	7.3	4.3	2.8	2.4	1.3

Printed markings





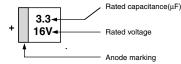
Ex.6.3V 10μF

A. A2 size



Ex.35V 0.47μF

B.C.D0 size



Ex.16V 3.3μF

Rated voltage 2.5V is marked "2V". Rated voltage 6.3V is marked "6V".

107

Taping polarity code

R

Pullout direction

R

100

Rated voltage code				па	ieu voita	ige 0.5v	15 IIIaik	eu ov.
Rated voltage(V)	2.5	4	6.3	10	16	20	25	35
Rated voltage code	e	G	J	A	C	D	E	V

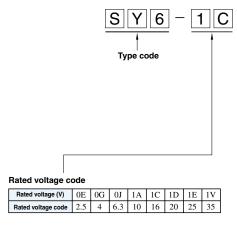
	Rated capacitance code					
Series name	SY	SYF/SKY				
Rated capacitance (µF)	J Size	P Size	A2, A Size			
10	A	Ā	106			
15	Е	Ē	156			
22	J	1	226			
33	-	-	336			
47	-	-	476			

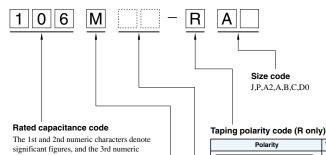
List of capacitance marking (J, P, A2, A size)

rking	Rated capacitance code						
Series name	SYF		SYF/SKY				
Rated capacitance (µF)	J Size	P Size	A2, A Size				
0.1	A	<u>A</u>	104				
0.15	E	<u>E</u>	154				
0.22	J	<u>J</u>	224				
0.33	N	<u>N</u>	334				
0.47	S	<u>s</u>	474				
0.68	W	W	684				
1	A	A	105				
1.5	Е	E	155				
2.2	J	J	225				
3.3	N	N	335				
4.7	S	S	475				
6.8	W	W	685				

Part No. system

Example: Type SY6: 16V. 10µF: A size





The 1st and 2nd numeric characters denote significant figures, and the 3rd numeric character the number of zero's placed after the significant figures denoting capacitance in pF. (Exponential of ten)

Example

Rated capacitance code
474
105
225

Additional code

Not entered for a standard type

Capacitance tolerance

Rated capacitance tolerance code	Rated capacitance tolerance
K	±10%
M	±20%



NOTE

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Lowprofile Hight type capacitors

Lowprofile Hight:1.2mm Max.

Specifications



Item	thigh rature -55°C +85°C +85°C Lea +125°C Tes eat, steady state Humidity) Tes ndurance Load life)			Performance		
Category temperatu	re range (°C)			-55 to +125 (Above 85°C use category voltage)		
Leakage curre	ated capacitance (%) at of loss angle ESR T to soldering heat -55°C t high atture L			Refer to standard ratings table		
Tolerance at rated ca	pacitance (%)			±10% (Except J size), ±20%		(120Hz)
Tangent of los	ss angle			Refer to standard ratings table		(120Hz)
ESR				Refer to standard ratings table		(100kHz)
		Test cond	itions: Soaking at 260°C for 5 seconds			(TOOKITZ)
] [J Size	P,A2 Size	
Resistance to sole	dering heat		Leakage current	The initial specified value or less	The initial specified value or less	
			Percentage of capacitance change	Within ±20% of initial value	Within ±10% of initial value	
			Tangent of loss angle	150% or less of the initial specified value	150% or less of the initial specified value	
		ſ	Percentage of capacitance change	Within -20 to 0% of the initial value	Within -10 to 0% of the initial value	
	+85°C		Tangent of loss angle	Refer to standard rating table	Refer to standard rating table	
	pacitance (%) s angle Test cond dering heat -55°C +85°C Leakage of the cond ddy state y) Test cond Test cond	Leakage current	1000% or less of the initial specified value	1000% or less of the initial specified value		
GI	+85°C		Percentage of capacitance change	Within 0 to 15% of the initial value	Within 0 to 10% of the initial value	
Characteristics at high and low temperature			Tangent of loss angle	Refer to standard rating table	Refer to standard rating table	
and low temperature	rent (µA) capacitance (%) oss angle R Test cond oldering heat -55°C +85°C Leakage - +125°C Test cond deady state lity) Test cond fife)	urrent data have been measured at derated voltage	*			
			Leakage current	1250% or less of the initial specified value	1250% or less of the initial specified value	
	+125°C		Percentage of capacitance change	Within 0 to 20% of the initial value	Within 0 to 12% of the initial value	
			Tangent of loss angle	Refer to standard rating table	Refer to standard rating table	
		Test cond	itions: Left at 40°C under 90 to 95% RH for 500 h	ours		
Damp heat, ste	ady state] [Leakage current	The initial specified value or less	The initial specified value or less	
(Humidi	tv)		Percentage of capacitance change	Within ±20% of initial value	Within ±10% of initial value	
	*/		Tangent of loss angle	200% or less of the initial specified value	150% or less of the initial specified value	
		Test cond	itions: Rated voltage applied at 85°C for 2000 hou	ırs;		
Enduran	tature Leak +125°C Test of the state and th		Leakage current	The initial specified value or less	The initial specified value or less	
(Load lif	+125°C Test: ut, steady state unidity) Test:		Percentage of capacitance change	Within ±20% of the initial value	Within ±10% of the initial value	
	thigh +85°C Leak: +125°C Test of the destriction of the search of the	[Tangent of loss angle	200% or less of the initial specified value	150% or less of the initial specified value	
Failure ra	ate		Less	than 1% / 1000 hour (Refer to TECHNICAL NOT	E)	
Others	thigh ature L +125°C teat, steady state Iumidity) T Indurance Load life)		Con	forms to IEC 60384-3: 1989 (JIS C5101-3: 1998	(1)	

* Relation between the rated and the 125°C category voltage.

Rated voltage(V)	2.5	4	6.3	10	16	20	25
105°C category voltage(V)	1.6	2.5	4	6.3	10	13	16

Dimension table

Rated capacitance (µF)	Rated capacitance code		2.5V	е		4V	G		6.3\	/ J		10V	A		16V	С	20V D	25V E
0.1	104																A2	
0.15	154																A2	
0.22	224																A2	
0.33	334														P		A2	
0.47	474														P		A2	A2
0.68	684											P			P		A2	A2
1	105											P	A2	J	P		A2	A2
1.5	155								P	A2	J	P	A2		P		A2	
2.2	225						A2	J	P	A2	J	P	A2		P	A2	A2	
3.3	335					P	A2	J	P	A2	J	P	A2			A2		
4.7	475	J		A2	J	P	A2	J	P	A2	J	P	A2			A2		
6.8	685	J		A2	J	P	A2	J	P	A2		P	A2					
10	106	J		A2	J	P	A2	J	P	A2		P	A2					
15	156			A2		P	A2		P	A2			A2					
22	226			A2		P	A2			A2								
33	336		P	A2			A2			A2								
47	476			A2			A2											
68	686																	





Lowprofile Hight type capacitors

Lowprofile Hight:1.2mm Max.

Standard ratings

Rated	Rated			ELNA	Leakage	T	angent of ti	he loss ang	le .	E.S.R.		Taping minimum	
voltage (V)	capacitance (µF) (120Hz)	Marking	EIA size code	size code	current (µA, or less)	−55°C		120Hz) 85°C	125°C	(Ω) (100kHz)	ELNA Part No.	packing pcs. (pcs/reel)	Note
	4.7	eS	1608	J	0.50	0.30	0.20	0.25	0.30	10.0	SYF-0E475M-RJ	4,000	
	4.7	e475	3216L	A2	0.50	0.12	0.08	0.10	0.12	8.0	SYF-0E475M-RA2	3,000	*
	6.8	eW	1608	J	0.50	0.30	0.20	0.25	0.30	10.0	SYF-0E685M-RJ	4,000	
	6.8	e685	3216L	A2	0.50	0.12	0.08	0.10	0.12	8.0	SYF-0E685M-RA2	3,000	*
	10	eA	1608	J	0.50	0.30	0.20	0.25	0.30	10.0	SYF-0E106M-RJ	4,000	
2.5	10	e106	3216L	A2	0.50	0.12	0.08	0.10	0.12	4.0	SYF-0E106M-RA2	3,000	*
	15	e156	3216L	A2	0.50	0.18	0.12	0.16	0.18	4.0	SYF-0E156M-RA2	3,000	*
	22	e226	3216L	A2	0.55	0.18	0.12	0.16	0.18	4.0	SYF-0E226M-RA2	3,000	*
	33	eN	2012	P	0.82	0.12	0.08	0.10	0.12	4.0	SYF-0E336M-RP	3,000	
	33	e336	3216L	A2	0.82	0.18	0.12	0.16	0.18	4.0	SYF-0E336M-RA2	3,000	
	47	e476	3216L	A2	1.17	0.18	0.12	0.16	0.18	4.0	SYF-0E476M-RA2	3,000	
	2.2	G225	3216L	A2	0.50	0.12	0.08	0.10	0.12	8.0	SYF-0G225M-RA2	3,000	*
	3.3	GN	2012	P	0.50	0.12	0.08	0.10	0.12	10.0	SYF-0G335M-RP	3,000	*
	3.3	G335	3216L	A2	0.50	0.12	0.08	0.10	0.12	8.0	SYF-0G335M-RA2	3,000	*
	4.7	GS	1608	J	0.50	0.30	0.20	0.25	0.30	10.0	SYF00G475M-RJ	4,000	
	4.7	GS	2012	P	0.50	0.12	0.20	0.10	0.12	5.5	SYF-0G475M-RP	3,000	*
	4.7	G475	3216L	A2	0.50	0.12	0.08	0.10	0.12	5.0	SYF-0G475M-RA2	3,000	*
	6.8	G473	1608	J	0.50	0.12	0.08	0.10	0.12	10.0	SYF-0G685M-RJ	4,000	
	6.8	GW	2012	P	0.50	0.30	0.20	0.23	0.30	5.5	SYF-0G685M-RP	3,000	*
				_								· ·	*
4	6.8	G685	3216L	A2	0.50	0.12	0.08	0.10	0.12	4.0	SYF-0G685M-RA2	3,000	_ ~
	10	GA	1608	J	0.50	0.30	0.20	0.25	0.30	10.0	SYF-0G106M-RJ	4,000	
	10	GA	2012	P	0.50	0.15	0.10	0.12	0.15	5.5	SYF-0G106M-RP	3,000	
	10	G106	3216L	A2	0.50	0.15	0.10	0.13	0.15	4.0	SYF-0G106M-RA2	3,000	
	15	GE	2012	P	0.60	0.15	0.10	0.12	0.15	4.5	SYF-0G156M-RP	3,000	
	15	G156	3216L	A2	0.60	0.15	0.10	0.13	0.15	4.0	SYF-0G156M-RA2	3,000	
	22	GJ	2012	P	0.88	0.15	0.10	0.12	0.15	4.5	SYF-0G226M-RP	3,000	
	22	G226	3216L	A2	0.88	0.18	0.12	0.16	0.18	2.8	SYF-0G226M-RA2	3,000	
	33	G336	3216L	A2	1.32	0.18	0.12	0.16	0.18	2.8	SYF-0G336M-RA2	3,000	
	47	G476	3216L	A2	1.88	0.24	0.16	0.19	0.24	2.8	SYF-0G476M-RA2	3,000	
	1.5	JE	2012	P	0.50	0.12	0.08	0.10	0.12	10.0	SYF-0J155M-RP	3,000	
	1.5	J155	3216L	A2	0.50	0.12	0.08	0.10	0.12	8.0	SYF-0J155M-RA2	3,000	
	2.2	JJ	1608	J	0.50	0.30	0.20	0.25	0.30	10.0	SYF-0J225M-RJ	4,000	
	2.2	JJ	2012	P	0.50	0.12	0.08	0.10	0.12	10.0	SYF-0J225M-RP	3,000	
	2.2	J225	3216L	A2	0.50	0.12	0.08	0.10	0.12	8.0	SYF-0J225M-RA2	3,000	
	3.3	JN	1608	J	0.50	0.30	0.20	0.25	0.30	10.0	SYF-0J335M-RJ	4,000	
	3.3	JN	2012	P	0.50	0.12	0.08	0.10	0.12	10.0	SYF-0J335M-RP	3,000	
	3.3	J335	3216L	A2	0.50	0.12	0.08	0.10	0.12	8.0	SYF-0J335M-RA2	3,000	
	4.7	JS	1608	J	0.50	0.30	0.20	0.25	0.30	8.5	SYF-0J475M-RJ	4,000	
	4.7	JS	2012	P	0.50	0.12	0.08	0.10	0.12	6.0	SYF-0J475M-RP	3,000	
6.3	4.7	J475	3216L	A2	0.50	0.12	0.08	0.10	0.12	4.0	SYF-0J475M-RA2	3,000	
	6.8	JW	1608	J	0.50	0.30	0.20	0.25	0.30	8.0	SYF-0J685M-RJ	4,000	
	6.8	JW	2012	P	0.50	0.12	0.08	0.10	0.12	6.0	SYF-0J685M-RP	3,000	
	6.8	J685	3216L	A2	0.50	0.15	0.10	0.13	0.15	4.0	SYF-0J685M-RA2	3,000	
	10	JA	1608	J	6.30	0.30	0.20	0.25	0.30	8.0	SYF-0J106M-RJ	4,000	
	10	JA	2012	P	0.63	0.15	0.10	0.12	0.15	6.0	SYF-0J106M-RP	3,000	
	10	J106	3216L	A2	0.63	0.13	0.08	0.12	0.13	4.0	SYF-0J106M-RA2	3,000	
	15	JE	2012	P	0.03	0.12	0.08	0.10	0.12	5.0	SYF-0J156M-RP	3,000	
	15	J156	3216L	A2	0.94	0.24	0.10	0.19	0.24	4.0	SYF-0J156M-RA2	3,000	
	22	J226	3216L 3216L	A2 A2			0.12	0.16	0.18	2.8		3,000	
					1.38	0.21					SYF-0J226M-RP		
	33	J336	3216L	A2	2.07	0.24	0.16	0.19	0.24	2.8	SYF-0J336M-RA2	3,000	







Lowprofile Hight type capacitors

Lowprofile Hight:1.2mm Max.

Standard ratings

Rated voltage	Rated capacitance	Marking	EIA	ELNA size	Leakage current	Ta	angent of t	he loss ang	gle	E.S.R. (Ω)	ELNA Part No.	Taping minimum packing pcs.	Note
(V)	(μF) (120Hz)	Warking	size code	code	(μA, or less)	−55°C	20°C	85°C	125°C	(100kHz)	ELIVIT att 110.	(pcs/reel)	Note
	0.68	AW	2012	P	0.50	0.12	0.08	0.10	0.12	28.0	SYF-1A684M-RP	3,000	
	1	AA	2012	P	0.50	0.12	0.08	0.10	0.12	10.0	SYF-1A105M-RP	3,000	
	1	A105	3216L	A2	0.50	0.09	0.06	0.08	0.09	8.0	SYF-1A105M-RA2	3,000	
	1.5	AE	1608	J	0.50	0.30	0.20	0.25	0.30	10.0	SYF-1A155M-RJ	4,000	
	1.5	AE	2012	P	0.50	0.12	0.08	0.10	0.12	10.0	SYF-1A155M-RP	3,000	
	1.5	A155	3216L	A2	0.50	0.12	0.08	0.10	0.12	8.0	SYF-1A155M-RA2	3,000	
	2.2	AJ	1608	J	0.50	0.30	0.20	0.25	0.30	13.0	SYF-1A225M-RJ	4,000	
	2.2	AJ	2012	P	0.50	0.12	0.08	0.10	0.12	10.0	SYF-1A225M-RP	3,000	
	2.2	A225	3216L	A2	0.50	0.12	0.08	0.10	0.12	8.0	SYF-1A225M-RA2	3,000	
10	3.3	AN	1608	J	0.50	0.30	0.20	0.25	0.30	10.0	SYF-1A335M-RJ	4,000	
10	3.3	AN	2012	P	0.50	0.12	0.08	0.10	0.12	10.0	SYF-1A335M-RP	3,000	
	3.3	A335	3216L	A2	0.50	0.12	0.08	0.10	0.12	8.0	SYF-1A335M-RA2	3,000	
	4.7	AS	1608	J	4.70	0.30	0.20	0.25	0.30	10.0	SYF-1A475M-RJ	4,000	
	4.7	AS	2012	P	0.50	0.12	0.08	0.10	0.12	6.0	SYF-1A475M-RP	3,000	
	4.7	A475	3216L	A2	0.50	0.12	0.08	0.10	0.12	4.0	SYF-1A475M-RA2	3,000	
	6.8	AW	2012	P	0.68	0.15	0.10	0.13	0.15	6.0	SYF-1A685M-RP	3,000	
	6.8	A685	3216L	A2	0.68	0.12	0.08	0.10	0.12	4.0	SYF-1A685M-RA2	3,000	
	10	AA	2012	P	1.00	0.21	0.14	0.18	0.21	6.0	SYF-1A106M-RP	3,000	
	10	A106	3216L	A2	1.00	0.12	0.08	0.10	0.12	4.0	SYF-1A106M-RA2	3,000	
	15	A156	3216L	A2	1.50	0.24	0.12	0.15	0.25	4.0	SYF-1A156M-RA2	3,000	
	0.33	CN	2012	P	0.50	0.09	0.06	0.07	0.09	28.0	SYF-1C334M-RP	3,000	
	0.47	CS	2012	P	0.50	0.09	0.06	0.07	0.09	28.0	SYF-1C474M-RP	3,000	
	0.68	CW	2012	P	0.50	0.09	0.06	0.07	0.09	28.0	SYF-1C684M-RP	3,000	
	1	CA	1608	J	0.50	0.30	0.20	0.25	0.30	10.0	SYF-1C105M-RJ	4,000	
16	1	CA	2012	P	0.50	0.09	0.06	0.07	0.09	25.0	SYF-1C105M-RP	3,000	
16	1.5	CE	2012	P	0.50	0.12	0.08	0.10	0.12	20.0	SYF-1C155M-RP	3,000	
	2.2	CJ	2012	P	0.50	0.12	0.08	0.10	0.12	20.0	SYF-1C225M-RP	3,000	
	2.2	C225	3216L	A2	0.50	0.09	0.06	0.08	0.09	8.0	SYF-1C225M-RA2	3,000	
	3.3	C335	3216L	A2	0.50	0.09	0.06	0.08	0.09	6.0	SYF-1C335M-RA2	3,000	
	4.7	C475	3216L	A2	0.75	0.09	0.06	0.08	0.09	6.0	SYF-1C475M-RA2	3,000	
	0.1	D104	3216L	A2	0.50	0.09	0.06	0.08	0.09	28.0	SYF-1D104M-RA2	3,000	
	0.15	D154	3216L	A2	0.50	0.09	0.06	0.08	0.09	25.0	SYF-1D154M-RA2	3,000	
	0.22	D224	3216L	A2	0.50	0.09	0.06	0.08	0.09	23.0	SYF-1D224M-RA2	3,000	
	0.33	D334	3216L	A2	0.50	0.09	0.06	0.08	0.09	20.0	SYF-1D334M-RA2	3,000	
20	0.47	D474	3216L	A2	0.50	0.09	0.06	0.08	0.09	15.0	SYF-1D474M-RA2	3,000	
	0.68	D684	3216L	A2	0.50	0.09	0.06	0.08	0.09	14.0	SYF-1D684M-RA2	3,000	
	1	D105	3216L	A2	0.50	0.09	0.06	0.08	0.09	10.0	SYF-1D105M-RA2	3,000	
	1.5	D155	3216L	A2	0.50	0.09	0.06	0.08	0.09	9.0	SYF-1D155M-RA2	3,000	
	2.2	D225	3216L	A2	0.50	0.09	0.06	0.08	0.09	7.0	SYF-1D225M-RA2	3,000	
	0.47	E474	3216L	A2	0.50	0.09	0.06	0.08	0.09	15.0	SYF-1E474M-RA2	3,000	
25	0.68	E684	3216L	A2	0.50	0.09	0.06	0.08	0.09	14.0	SYF-1E684M-RA2	3,000	
	1	E105	3216L	A2	0.50	0.09	0.06	0.08	0.09	13.0	SYF-1E105M-RA2	3,000	

SKY-SYL Specifications, Dimension table TANTALUM CHIP CAPACITORS (CHIPCON)



Resin mold chip type capacitors

Standard Type

Specifications



Item				Performance		
Category temperatu	ire range (°C)			55 to +125 (Above 85°C use category voltage)		
Leakage curre	<u> </u>			Refer to standard ratings table		
Tolerance at rated ca	apacitance (%)			±10%(Except SY9), ±20%		(120Hz)
Tangent of los	ss angle			Refer to standard ratings table		(120Hz)
ESR				Refer to standard ratings table		(100kHz)
		Test cond	itions: Soaking at 260°C for 5 seconds	<u> </u>		(TOOKIL)
				SY5.SY6.SY7.SY8.SY9.SYL	SY1.SY2.SY3.SY4	¬
Resistance to sole	dering heat		Leakage current	The initial specified value or less	The initial specified value or less	-
	C		Percentage of capacitance change	Within ±10% of initial value	Within ±5% of initial value	
			Tangent of loss angle	150% or less of the initial specified value	The initial specified value or less	-
			rangent or 1035 angle	130 % of less of the initial specified value	The initial specified value of less	
	55°C	1	Percentage of capacitance change	Within -10 to 0% of the initial value	Within -10 to 0% of the initial value	
	-33 C		Tangent of loss angle	Refer to standard rating table	Refer to standard rating table	
			Leakage current	1000% or less of the initial specified value	1000% or less of the initial specified value	7
Characteristics at high	+85°C		Percentage of capacitance change	Within 0 to 10% of the initial value	Within 0 to 10% of the initial value	
Characteristics at high			Tangent of loss angle	Refer to standard rating table	Refer to standard rating table	
and low temperature		Leakage o	current data have been measured at derated voltage*			
		l í	Leakage current	1250% or less of the initial specified value	1250% or less of the initial specified value	
	+125°C		Percentage of capacitance change	Within 0 to 12% of the initial value	Within 0 to 12% of the initial value	
			Tangent of loss angle	Refer to standard rating table	Refer to standard rating table	
		Test cond	itions: Left at 40°C under 90 to 95% RH for 500 ho	urs		
Damp heat, ste	ady state	l í	Leakage current	The initial specified value or less	The initial specified value or less	
(Humidit	tv)		Percentage of capacitance change	Within ±10% of initial value	Within ±5% of initial value	
(Tunner	-97		Tangent of loss angle	150% or less of the initial specified value	The initial specified value or less]
		Test cond	itions: Rated voltage applied at 85°C for 2000 hour	s;		
Enduran	ice	[Leakage current	The initial specified value or less	The initial specified value or less	7
(Load lif	fe)		Percentage of capacitance change	Within ±10% of initial value	Within ±10% of initial value	
, , , , , , , , , , , , , , , , , , , ,			Tangent of loss angle	150% or less of the initial specified value	The initial specified value or less	
Failure ra	rated capacitance (%) int of loss angle ESR Test of the eto soldering heat -55°C at high rature +125°C Leak +125°C Test of the eto soldering heat Test of the eto soldering heat		Less th	an 1% / 1000 hour (Refer to TECHNICAL NOT	E)	
Others	ngent of loss angle ESR ance to soldering heat -55°C +85°C +85°C +125°C ap heat, steady state (Humidity) Endurance (Load life) Failure rate		Confe	orms to IEC 60384-3 : 1989 (JIS C5101-3 : 1998)	

* Relation between the rated and the 125°C category voltage.

Rated voltage(V)	2.5	4	6.3	10	16	20	25	35
105°C category voltage(V)	1.6	2.5	4	6.3	10	13	16	22

SKY Type Dimension table

Rated capacitance (µF)	Rated capacitance code		5V e		4	V	G		6.	3V	J		10	0V	Α		16	6V	С		20	V	D		25	5V	E		35	ōV	٧
0.1	104																											Α			
0.15	154																											Α			
0.22	224																											Α			Į.
0.33	334																											Α			
0.47	474																							A				Α	В		
0.68	684																			A				A				Α	В		
1	105															A				A				A				Α	В		
1.5	155											A				A				A				Α	В			Α	В	C	
2.2	225							A				Α				A				A	В			A	В				В	C	
3.3	335			A				A				Α				A	В			A	В				В				В	C	
4.7	475			A				A				A	В			A	В			A	В				В	C					D0
6.8	685			A				A	В			Α	В			A	В			A	В	C			В	C				C	D0
10	106			A	В			A	В			A	В			A	В	C			В	C				C	D0			C	D0
15	156	A		A	В			Α	В			Α	В	C			В	C				C	D0			C	D0				D0
22	226	A		A	В			A	В	C		Α	В	C			В	C	D0			C	D0				D0				D0
33	336	A		A	В	C		A	В	C			В	C	D0			C	D0				D0				D0				
47	476	A		A	В	C		Α	В	C	D0		В	C	D0			C	D0				D0								
68	686	A	В	A	В	C	D0		В	C	D0			C	D0				D0												
100	107	A	В		В	C	D0		В	C	D0			C	D0				D0												
150	157		В		В	C	D0			C	D0				D0																
220	227		В		В	C	D0				D0				D0																
330	337						D0				D0																				
470	477						D0																								
680	687																														





Standard Type

Standard ratings

Rated voltage	Rated capacitance (uF)	Marking	EIA size code	ELNA size	Leakage current	T	angent of t (less)(he loss ang 120Hz)	le	E.S.R. (Ω)	ELNA Part No.	Taping minimum packing pcs.	Note
(V)	(μF) (120Hz)			code	(μA, or less)	−55°C	20°C	85°C	125°C	(100kHz)		(pcs/reel)	
	15	e156	3216	A	0.50	0.09	0.06	0.08	0.09	4.0	SY3-0E156M-RA	2,000	*
	22	e226	3216	A	0.55	0.12	0.08	0.10	0.12	2.8	SY4-0E226M-RA	2,000	*
	33	e336	3216	A	0.82	0.18	0.08	0.10	0.12	2.5	SY5-0E336M-RA	2,000	
	47	e476	3216	A	1.17	0.18	0.12	0.16	0.18	2.5	SY6-0E476M-RA	2,000	
2.5	68	e686	3216	A	1.70	0.27	0.18	0.23	0.27	2.0	SY7-0E686M-RA	2,000	
2.3	68		3528	В	1.70	0.12	0.08	0.10	0.12	1.5	SY5-0E686M-RB	2,000	*
	100	e107	3216	A	2.50	0.27	0.18	0.23	0.27	2.0	SY8-0E107M-RA	2,000	
	100		3528	В	2.50	0.12	0.08	0.10	0.12	1.0	SY6-0E107M-RB	2,000	
	150		3528	В	3.75	0.18	0.12	0.16	0.18	1.0	SY7-0E157M-RB	2,000	
	220		3528	В	5.50	0.27	0.18	0.23	0.27	1.0	SY8-0E157M-RB	2,000	
	3.3	G335	3216	A	0.50	0.09	0.06	0.07	0.09	8.0	SY1-0G335M-RA	2,000	*
	4.7	G475	3216	A	0.50	0.12	0.08	0.10	0.12	4.0	SY2-0G475M-RA	2,000	
	6.8	G685	3216	A	0.50	0.12	0.08	0.10	0.12	4.0	SY2-0G685M-RA	2,000	
	10	G106	3216	A	0.50	0.12	0.08	0.10	0.12	4.0	SY3-0G106M-RA	2,000	
	10		3528	В	0.50	0.09	0.06	0.07	0.09	2.5	SY1-0G106M-RB	2,000	*
	15	G156	3216	A	0.60	0.12	0.08	0.10	0.12	3.0	SY4-0G156M-RA	2,000	
	15		3528	В	0.60	0.12	0.08	0.10	0.12	3.5	SY2-0G156M-RB	2,000	*
	22	G226	3216	A	0.88	0.12	0.08	0.10	0.12	2.5	SY5-0G226M-RA	2,000	
	22		3528	В	0.88	0.09	0.06	0.08	0.09	1.5	SY3-0G226M-RB	2,000	
	33	G336	3216	A	1.32	0.15	0.10	0.12	0.15	2.5	SY6-0G336M-RA	2,000	
	33		3528	В	1.32	0.12	0.08	0.10	0.12	1.5	SY4-0G336M-RB	2,000	
	33		6032	C	1.32	0.09	0.06	0.07	0.09	2.2	SY1-0G336M-RC	500	*
	47	G476	3216	A	1.88	0.15	0.10	0.13	0.15	2.5	SY7-0G476M-RA	2,000	
	47		3528	В	1.88	0.12	0.08	0.10	0.12	1.5	SY5-0G476M-RB	2,000	
_ ,	47		6032	C	1.88	0.12	0.06	0.08	0.12	1.0	SY2-0G476M-RC	500	
4	68	G686	3216	A	2.72	0.24	0.16	0.19	0.24	2.5	SY8-0G686M-RA	2,000	
	68		3528	В	2.72	0.12	0.08	0.10	0.12	1.5	SY6-0G686M-RB	2,000	
	68		6032	C	2.72	0.09	0.06	0.08	0.09	1.0	SY3-0G686M-RC	500	
	68		7343	D0	2.72	0.09	0.06	0.07	0.09	0.7	SY1-0G686M-RD0	500	
	100		3528	В	4.00	0.15	0.10	0.13	0.15	1.0	SY7-0G107M-RB	2,000	
	100		6032	C	4.00	0.12	0.08	0.10	0.12	0.8	SY4-0G107M-RC	500	
	100		7343	D0	4.00	0.12	0.08	0.10	0.12	0.8	SY2-0G107M-RD0	500	*
	150		3528	В	6.00	0.24	0.16	0.19	0.24	1.0	SY8-0G157M-RB	2,000	
	150		6032	C	6.00	0.15	0.10	0.13	0.15	0.8	SY5-0G157M-RC	500	
	150		7343	D0	6.00	0.12	0.08	0.10	0.12	0.8	SY3-0G157M-RD0	500	
	220		3528	В	88.00	0.27	0.18	0.23	0.27	1.0	SY9-0G227M-RB	2,000	
	220		6032	С	8.80	0.18	0.12	0.15	0.18	0.7	SY6-0G227M-RC	500	
	220		7343	D0	8.80	0.12	0.08	0.10	0.12	1.0	SY4-0G227M-RD0	500	
	330		7343	D0	13.20	0.21	0.14	0.18	0.21	0.7	SY5-0G337M-RD0	500	
	470		7343	D0	18.80	0.24	0.16	0.21	0.24	0.3	SY6-0G477M-RD0	500	





Standard Type

Standard ratings

Rated voltage (V)	Rated capacitance (µF) (120Hz)	Marking	EIA size code	ELNA size code	Leakage current (µA, or less)	_55°C	angent of the (less)(1)	he loss ang 120Hz) 85°C	le 125°C	E.S.R. (Ω) (100kHz)	ELNA Part No.	Taping minimum packing pcs. (pcs/reel)	Note
	2.2	J225	3216	A	0.50	0.09	0.06	0.07	0.09	8.0	SY1-0J225M-RA	2,000	*
	3.3	J335	3216	Α	0.50	0.09	0.06	0.08	0.09	7.0	SY2-0J335M-RA	2,000	
	4.7	J475	3216	A	0.50	0.09	0.06	0.10	0.09	4.0	SY2-0J475M-RA	2,000	
	6.8	J685	3216	Α	0.50	0.09	0.06	0.08	0.09	3.5	SY3-0J685M-RA	2,000	
	6.8		3528	В	0.50	0.09	0.06	0.07	0.09	3.0	SY1-0J685M-RB	2,000	*
	10	J106	3216	A	0.63	0.12	0.08	0.10	0.12	3.0	SY4-0J106M-RA	2,000	
	10		3528	В	0.63	0.09	0.06	0.08	0.09	3.0	SY2-0J106M-RB	2,000	
	15	J156	3216	A	0.94	0.12	0.08	0.10	0.12	3.0	SY5-0J156M-RA	2,000	
	15		3528	В	0.94	0.09	0.06	0.08	0.09	2.0	SY3-0J156M-RB	2,000	
	22	J226	3216	A	1.38	0.15	0.10	0.13	0.05	2.5	SY6-0J226M-RA	2,000	
	22		3528	В	1.38	0.12	0.08	0.10	0.13	1.5	SY4-0J226M-RB	2,000	
	22		6032	C	1.38	0.12	0.06	0.10	0.12	1.0	SY1-0J226M-RC	500	*
	33		3216	A	2.07	0.09	0.00	0.07	0.09	2.5	SY7-0J336M-RA	2,000	
		J336		B B	2.07				0.13	1.5			
	33		3528			0.12	0.08	0.10			SY5-0J336M-RB	2,000	
6.3	33		6032	C	2.07	0.09	0.06	0.08	0.09	1.0	SY2-0J336M-RC	500	
	47	J476	3216	A	2.96	0.24	0.16	0.19	0.24	2.5	SY8-0J476M-RA	2,000	
	47		3528	В	2.96	0.15	0.10	0.13	0.15	1.0	SY6-0J476M-RB	2,000	
	47		6032	С	2.96	0.09	0.06	0.08	0.09	1.0	SY3-0J476M-RC	500	
	47		7343	D0	2.96	0.09	0.06	0.07	0.09	0.7	SY1-0J476M-RD0	500	*
	68		3528	В	4.28	0.15	0.10	0.13	0.15	1.0	SY7-0J686M-RB	2,000	
	68		6032	С	4.28	0.12	0.08	0.10	0.12	0.8	SY4-0J686M-RC	500	
	68		7343	D0	4.28	0.09	0.06	0.08	0.09	0.8	SY2-0J686M-RD0	500	*
	100		3528	В	6.30	0.18	0.12	0.15	0.18	1.0	SY8-0J107M-RB	2,000	
	100		6032	C	6.30	0.15	0.10	0.13	0.15	0.7	SY5-0J107M-RC	500	
	100		7343	D0	6.30	0.12	0.08	0.10	0.12	0.8	SY3-0J107M-RD0	500	
	150		6032	C	9.45	0.18	0.12	0.15	0.18	0.7	SY6-0J157M-RC	500	
	150		7343	D0	9.45	0.12	0.08	0.10	0.12	1.0	SY4-0J157M-RD0	500	
	220		7343	D0	13.86	0.18	0.12	0.16	0.18	0.5	SY5-0J227M-RD0	500	
	330		7343	D0	20.79	0.24	0.16	0.20	0.24	0.5	SY6-0J337M-RD0	500	
	1.5	A155	3216	A	0.50	0.09	0.06	0.07	0.09	8.0	SY1-1A155M-RA	2,000	*
	2.2	A225	3216	A	0.50	0.09	0.06	0.08	0.09	7.0	SY2-1A225M-RA	2,000	
	3.3	A335	3216	Α	0.50	0.09	0.06	0.08	0.09	5.0	SY2-1A335M-RA	2,000	
	4.7	A475	3216	Α	0.50	0.09	0.06	0.08	0.09	4.5	SY3-1A475M-RA	2,000	
	4.7		3528	В	0.50	0.09	0.06	0.07	0.09	3.0	SY1-1A475M-RB	2,000	*
	6.8	A685	3216	Α	0.68	0.09	0.06	0.08	0.09	3.0	SY4-1A685M-RA	2,000	
	6.8		3528	В	0.68	0.09	0.06	0.08	0.09	3.0	SY2-1A685M-RB	2,000	*
	10	A106	3216	Α	1.00	0.12	0.08	0.10	0.12	3.0	SY5-1A106M-RA	2,000	
	10		3528	В	1.00	0.09	0.06	0.08	0.09	2.0	SY3-1A106M-RB	2,000	
	15	A156	3216	Α	1.50	0.15	0.10	0.13	0.15	3.0	SY6-1A156M-RA	2,000	
	15		3528	В	1.50	0.09	0.06	0.08	0.09	2.0	SY4-1A156M-RB	2,000	
	15		6032	C	1.50	0.09	0.06	0.07	0.09	1.0	SY1-1A156M-RC	500	*
	22	A226	3216	A	2.20	0.18	0.12	0.16	0.18	2.5	SY7-1A226M-RA	2,000	
10	22		3528	В	2.20	0.12	0.08	0.10	0.12	2.0	SY5-1A226M-RB	2,000	
	22		6032	C	2.20	0.09	0.06	0.08	0.09	1.0	SY2-1A226M-RC	500	
	33		3528	В	3.30	0.05	0.08	0.10	0.03	1.5	SY6-1A336M-RB	2,000	
	33		6032	C	3.30	0.12	0.06	0.10	0.12	1.0	SY3-1A336M-RC	500	
	33		7343	D0	3.30	0.09	0.06	0.08	0.09	0.7	SY1-1A336M-RD0	500	*
	47		3528	В	4.70	0.15	0.10	0.13	0.15	1.0	SY7-1A476M-RB	2,000	
	47		6032	C	4.70	0.09	0.06	0.08	0.09	0.9	SY4-1A476M-RC	500	
	47		7343	D0	4.70	0.09	0.06	0.08	0.09	0.8	SY2-1A476M-RD0	500	1
	68		6032	С	6.80	0.12	0.08	0.10	0.12	0.8	SY5-1A686M-RC	500	
	68		7343	D0	6.80	0.09	0.06	0.08	0.09	0.6	SY3-1A686M-RD0	500	
	100		6032	С	10.00	0.15	0.10	0.13	0.15	0.7	SY6-1A107M-RC	500	
	100		7343	D0	10.00	0.12	0.08	0.10	0.12	0.6	SY4-1A107M-RD0	500	
	150		7343	D0	15.00	0.15	0.10	0.13	0.15	0.7	SY5-1A157M-RD0	500	







Standard Type

Standard ratings

Rated voltage	Rated capacitance (µF)	Marking	EIA size code	ELNA size	Leakage current			120Hz)	le	E.S.R. (Ω)	ELNA Part No.	Taping minimum packing pcs.	Note
(V)	(120Hz)	~		code	(μA, or less)	−55°C	20°C	85°C	125°C	(100kHz)		(pcs/reel)	
	1	C105	3216	A	0.50	0.09	0.05	0.07	0.09	7.0	SY1-1C105M-RA	2,000	
	1.5	C155	3216	A	0.50	0.09	0.06	0.08	0.09	7.0	SY2-1C155M-RA	2,000	
	2.2	C225	3216	A	0.50	0.09	0.06	0.08	0.09	5.0	SY2-1C225M-RA	2,000	
	3.3	C335	3216	A	0.50	0.09	0.06	0.08	0.09	4.5	SY3-1C335M-RA	2,000	
	3.3		3528	В	0.50	0.09	0.06	0.07	0.09	3.0	SY1-1C335M-RB	2,000	*
	4.7	C475	3216	A	0.75	0.09	0.06	0.08	0.09	4.0	SY4-1C475M-RA	2,000	
	4.7		3528	В	0.75	0.09	0.06	0.08	0.09	3.0	SY2-1C475M-RB	2,000	*
	6.8	C685	3216	A	1.08	0.12	0.08	0.10	0.12	3.5	SY5-1C685M-RA	2,000	
	6.8		3528	В	1.08	0.09	0.06	0.08	0.09	2.5	SY3-1C685M-RB	2,000	
	10	C106	3216	A	1.60	0.12	0.08	0.10	0.12	4.0	SY6-1C106M-RA	2,000	
	10		3528	В	1.60	0.09	0.06	0.08	0.09	2.0	SY4-1C106M-RB	2,000	
16	10		6032	C	1.60	0.09	0.06	0.07	0.09	2.2	SY1-1C106M-RC	500	*
	15		3528	В	2.40	0.09	0.06	0.08	0.09	2.0	SY5-1C156M-RB	2,000	
	15		6032	C	2.40	0.09	0.06	0.08	0.09	2.0	SY2-1C156M-RC	500	*
	22		3528	В	3.52	0.12	0.06	0.10	0.12	2.0	SY6-1C226M-RB	2,000	
	22		6032	С	3.52	0.09	0.06	0.08	0.09	1.0	SY3-1C226M-RC	500	
	22		7343	D0	3.52	0.09	0.06	0.07	0.09	0.7	SY1-1C226M-RD0	500	*
	33		6032	C	5.28	0.09	0.06	0.08	0.09	1.1	SY4-1C336M-RC	500	
	33		7343	D0	5.28	0.09	0.06	0.08	0.09	1.0	SY2-1C336M-RD0	500	*
	47		6032	С	7.52	0.12	0.08	0.10	0.12	0.8	SY5-1C476M-RC	500	
	47		7343	D0	7.52	0.09	0.06	0.08	0.09	0.7	SY3-1C476M-RD0	500	
	68		7343	D0	10.80	0.09	0.06	0.08	0.09	0.6	SY4-1C686M-RD0	500	
	100		7343	D0	16.00	0.15	0.10	0.13	0.15	0.6	SY5-1C107M-RD0	500	
	0.68	D684	3216	Α	0.50	0.09	0.05	0.06	0.09	10.0	SY1-1D684M-RA	2,000	*
	1	D105	3216	A	0.50	0.09	0.05	0.06	0.09	7.5	SY2-1D105M-RA	2,000	
	1.5	D155	3216	A	0.50	0.09	0.06	0.08	0.09	6.0	SY2-1D155M-RA	2,000	
	2.2	D225	3216	A	0.50	0.09	0.06	0.08	0.09	5.0	SY3-1D225M-RA	2,000	
	2.2		3528	В	0.50	0.09	0.06	0.07	0.09	5.0	SY1-1D225M-RB	2,000	*
	3.3	D335	3216	A	0.66	0.09	0.06	0.08	0.09	4.0	SY4-1D335M-RA	2,000	
	3.3		3528	В	0.66	0.09	0.06	0.08	0.09	3.8	SY2-1D335M-RB	2,000	
	4.7	D475	3216	A	0.94	0.09	0.06	0.08	0.09	4.0	SY5-1D475M-RA	2,000	
	4.7		3528	В	0.94	0.09	0.06	0.08	0.09	3.0	SY3-1D475M-RB	2,000	
	6.8	D685	3216	A	1.36	0.12	0.08	0.10	0.12	4.0	SY6-1D685M-RA	2,000	
20	6.8		3528	В	1.36	0.09	0.06	0.08	0.09	3.0	SY4-1D685M-RB	2,000	
	6.8		6032	C	1.36	0.09	0.06	0.07	0.09	2.5	SY1-1D685M-RC	500	*
	10		3528	В	2.00	0.09	0.06	0.08	0.09	2.0	SY5-1D106M-RB	2,000	
	10		6032	C	2.00	0.09	0.06	0.08	0.09	2.5	SY2-1D106M-RC	500	
	15		6032	C	3.00	0.09	0.06	0.08	0.09	1.7	SY3-1D156M-RC	500	
			7343	D0	3.00	0.09	0.06	0.08	0.09	2.0		500	*
	15										SY1-1D156M-RD0		~
	22		6032	C	4.40	0.09	0.06	0.08	0.09	1.5	SY4-1D226M-RC	500	
	22		7343	D0	4.40	0.09	0.06	0.08	0.09	0.8	SY2-1D226M-RD0	500	
	33		7343	D0	6.60	0.09	0.06	0.08	0.09	0.7	SY3-1D336M-RD0	500	
	47		7343	D0	9.40	0.09	0.06	0.08	0.09	0.7	SY4-1D476M-RD0	500	





Standard Type

Standard ratings

Rated voltage	Rated capacitance (µF)	Marking	EIA size code	ELNA size	Leakage current		. ` /`	120Hz)		E.S.R. (Ω)	ELNA Part No.	Taping minimum packing pcs.	Note
(V)	(120Hz)	F.15.1	2216	code	(μA, or less)	−55°C	20°C	85°C	125°C	(100kHz)	GT11 45 45 45 5 5	(pcs/reel)	
	0.47	E474	3216	A	0.50	0.09	0.05	0.06	0.09	10.0	SY1-1E474M-RA	2,000	
	0.68	E684	3216	A	0.50	0.09	0.05	0.06	0.09	9.0	SY2-1E684M-RA	2,000	
	1	E105	3216	A	0.50	0.09	0.06	0.08	0.09	7.0	SY2-1E105M-RA	2,000	
	1.5	E155	3216	A	0.50	0.09	0.06	0.08	0.09	6.5	SY3-1E155M-RA	2,000	١.
	1.5		3528	В	0.50	0.09	0.06	0.07	0.09	5.0	SY1-1E155M-RB	2,000	*
	2.2	E225	3216	A	0.55	0.09	0.06	0.08	0.09	6.0	SY4-1E225M-RA	2,000	
	2.2		3528	В	0.55	0.09	0.06	0.08	0.09	5.0	SY2-1E225M-RB	2,000	
	3.3		3528	В	0.82	0.09	0.06	0.08	0.09	4.0	SY3-1E335M-RB	2,000	
25	4.7		3528	В	1.17	0.09	0.06	0.08	0.09	3.5	SY4-1E475M-RB	2,000	
	4.7		6032	C	1.17	0.09	0.06	0.07	0.09	2.5	SY1-1E475M-RC	500	
	6.8		3528	В	1.70	0.12	0.08	0.10	0.12	2.0	SY5-1E685M-RB	2,000	
	6.8		6032	C	1.70	0.09	0.06	0.08	0.09	2.0	SY2-1E685M-RC	500	
	10		6032	C	2.50	0.09	0.06	0.08	0.09	1.5	SY3-1E106M-RC	500	
	10		7343	D0	2.50	0.09	0.06	0.07	0.09	1.2	SY1-1E106M-RD0	500	
	15		6032	C	3.75	0.09	0.06	0.06	0.09	1.0	SY4-1E156M-RC	500	
	15		7343	D0	3.75	0.09	0.06	0.08	0.09	1.0	SY2-1E156M-RD0	500	
	22		7343	D0	5.50	0.09	0.06	0.08	0.09	0.8	SY3-1E226M-RD0	500	
	33		7343	D0	8.25	0.09	0.06	0.08	0.09	0.7	SY3-1E226M-RD0	500	
	0.1	V104	3216	A	0.50	0.09	0.05	0.08	0.09	28.0	SY1-1V104M-RA	2,000	
	0.15	V154	3216	Α	0.50	0.09	0.05	0.08	0.09	24.0	SY1-1V154M-RA	2,000	
	0.22	V224	3216	Α	0.50	0.09	0.05	0.08	0.09	20.0	SY1-1V224M-RA	2,000	
	0.33	V334	3216	Α	0.50	0.09	0.05	0.08	0.09	15.0	SY1-1V334M-RA	2,000	
	0.47	V474	3216	Α	0.50	0.09	0.05	0.08	0.09	11.0	SY2-1V474M-RA	2,000	
	0.47		3528	В	0.50	0.09	0.04	0.06	0.09	11.0	SY1-1V474M-RB	2,000	
	0.68	V684	3216	A	0.50	0.09	0.04	0.06	0.09	8.0	SY2-1V684M-RA	2,000	
	0.68		3528	В	0.50	0.09	0.04	0.06	0.09	8.0	SY1-1V684M-RB	2,000	
	1	V105	3216	A	0.50	0.09	0.06	0.08	0.09	7.0	SY3-1V105M-RA	2,000	
	1		3528	В	0.50	0.09	0.04	0.06	0.09	6.0	SY1-1V105M-RB	2,000	
	1.5	V155	3216	A	0.52	0.09	0.04	0.08	0.09	4.0	SY4-1V155M-RA	2,000	
	1.5		3528	В	0.52	0.09	0.06	0.08	0.09	5.0	SY2-1V155M-RB	2,000	
35	1.5		6032	C	0.52	0.09	0.06	0.03	0.09	4.5	SY1-1V155M-RC	500	
33	2.2		3528	В	0.32	0.09	0.06	0.07	0.09	4.0	SY3-1V225M-RB	2,000	
	2.2			С	0.77	0.09				3.5			
			6032				0.06	0.07	0.09		SY1-1V225M-RC	500	
	3.3		3528	В	1.15	0.09	0.06	0.08	0.09	4.0	SY4-1V335M-RB	2,000	
	3.3		6032	C	1.15	0.09	0.06	0.07	0.09	3.0	SY1-1V335M-RC	500	
	4.7		6032	С	1.64	0.09	0.06	0.08	0.09	2.0	SY2-1V475M-RC	500	
	4.7		7343	D0	1.64	0.09	0.06	0.07	0.09	1.5	SY1-1V475M-RD0	500	
	6.8		6032	С	2.38	0.09	0.06	0.08	0.09	1.8	SY3-1V685M-RC	500	
	6.8		7343	D0	2.38	0.09	0.06	0.07	0.09	1.3	SY1-1V685M-RD0	500	
	10		6032	С	3.50	0.09	0.06	0.07	0.09	1.5	SY4-1V106M-RC	500	
	10		7343	D0	3.50	0.09	0.06	0.08	0.09	1.0	SY2-1V106M-RD0	500	
	15		7343	D0	5.25	0.09	0.06	0.08	0.09	0.8	SY3-1V156M-RD0	500	
	22		7343	D0	7.70	0.12	0.08	0.10	0.12	0.7	SY4-1V226M-RD0	500	



Standard ratings Type SYL (LOW ESR)

Rated voltage (V)	Rated capacitance (µF) (120Hz)	Marking (P, A2, A)	EIA size code	ELNA size symbol	Leakage current (µA, or less)	_55°C		he loss ang 120Hz) 85°C	gle 125°C	E.S.R. (Ω) (100kHz)	Allouable Ripple Current (Arms) (100kHz)	ELNA Part No.	Taping minimum packing pcs. (pcs/reel)	Note
()	10	GĀ	2012	P	0.50	0.15	0.1	0.12	0.15	1.2	0.13	SYL-0G106M-RP	3,000	\vdash
	22	G226	3216L	A2	0.88	0.13	0.12	0.16	0.13	1.0	0.16	SYL-0G226M-RA2	3,000	
	33	G336	3216L	A2	1.32	0.10	0.12	0.18	0.10	1.0	0.16	SYL-0G336M-RA2	3,000	
	33	G336	3216	A	1.32	0.15	0.1	0.13	0.15	0.8	0.19	SYL-0G336M-RA	2.000	
	47	G476	3216	A	1.88	0.15	0.1	0.13	0.15	0.8	0.19	SYL-0G476M-RA	2,000	
4	47	_	3528	В	1.88	0.12	0.08	0.1	0.12	0.8	0.19	SYL-0G476M-RB	2,000	
	100	_	3528	В	4.00	0.12	0.1	0.13	0.15	0.7	0.15	SYL-0G107M-RB	2,000	
	100	_	6032	C	4.00	0.12	0.08	0.1	0.12	0.3	0.41	SYL-0G107M-RC	500	
	220	_	7343	D0	8.80	0.12	0.08	0.1	0.12	0.1	0.87	SYL-0G227M-RD0	500	
	330	_	7343	D0	13.20	0.12	0.14	0.18	0.12	0.1	0.87	SYL-0G337M-RD0	500	
	3.3	JN	2012	P	0.50	0.12	0.08	0.096	0.12	3.0	0.09	SYL-0J335M-RP	3,000	\vdash
	4.7	JS	2012	P	0.50	0.12	0.08	0.096	0.12	2.0	0.10	SYL-0J475M-RP	3,000	
	4.7	J475	3216L	A2	0.50	0.12	0.08	0.050	0.12	2.0	0.10	SYL-0J475M-RA2	3,000	
	10	JĀ	2012	P	0.63	0.12	0.1	0.12	0.12	1.2	0.11	SYL-0J106M-RP	3,000	
	10	J106	3216L	A2	0.63	0.13	0.1	0.12	0.13	1.2	0.13	SYL-0J106M-RA2	3,000	
	10	J106	3216L 3216	A	0.63	0.12	0.08	0.1	0.12	1.2	0.14	SYL-0J106M-RA2	2,000	
	22	J226	3216	A	1.38	0.12	0.08	0.1	0.12	0.8	0.10	SYL-0J226M-RA	2,000	
6.3	33	J336	3216	A	2.07	0.15	0.1	0.13	0.15	0.8	0.19	SYL-0J336M-RA	2,000	
0.5	33		3528	В	2.07	0.13	0.1	0.13	0.13	0.8	0.19	SYL-0J336M-RB	2,000	
	47		3528	В	2.96	0.12	0.08	0.13	0.12	1.0	0.19	SYL-0J330M-RB	2,000	-
	47		6032	C	2.96	0.13	0.1	0.13	0.13	0.4	0.17	SYL-0J476M-RC	500	
	100		3528	В	6.30	0.09	0.00	0.08	0.09	0.4	0.33	SYL-0J107M-RB	2,000	
	100			С	6.30					0.7	0.21	SYL-0J107M-RB SYL-0J107M-RC	500	
	100	_	6032 7343	D0	6.30	0.15 0.12	0.1 0.08	0.13	0.15 0.12	0.23	0.45	SYL-0J107M-RC SYL-0J107M-RD0	500	
	220			D0 D0						0.15	0.46		500	
	2.2		7343 2012	P	13.90 0.50	0.18	0.12	0.16	0.18	5.0	0.79	SYL-0J227M-RD0		\vdash
	3.3	A J		A2	0.50	0.12	0.08			3.0	0.07	SYL-1A225M-RP	3,000 3,000	
	3.3 4.7	A335	3216L		0.50	0.12	0.08	0.1	0.12			SYL-1A335M-RA2	3,000	
	4.7	A475	3216L	A2 A	0.50	0.15	0.1	0.13	0.15	2.0	0.11	SYL-1A475M-RA2	1	
	10	A475	3216		1.00	0.09	0.06	0.08	0.09		0.12	SYL-1A475M-RA	2,000	-
		A106	3216L	A2		0.24	0.16	0.21	0.24	1.5	0.13	SYL-1A106M-RA2	3,000	
	10 22	A106	3216	A	1.00	0.12	0.08	0.1	0.12	1.0	0.15	SYL-1A106M-RA	2,000	
10		_	3528	В	2.20	0.12	0.08	0.1	0.12	1.0	0.17	SYL-1A226M-RB	2,000	
	33	_	3528	В	3.30	0.12	0.08	0.1	0.12	0.8	0.19	SYL-1A336M-RB	2,000	
	33		6032	С	3.30	0.09	0.06	0.08	0.09	0.375	0.37	SYL-1A336M-RC	500	
	47	_	3528	В	4.70	0.15	0.1	0.13	0.15	0.7	0.21	SYL-1A476M-RB	2,000	
	47	_	6032	C	4.70	0.09	0.06	0.08	0.09	0.4	0.35	SYL-1A476M-RC	500	
	47	_	7343	D0	4.70	0.09	0.06	0.08	0.09	0.3	0.50	SYL-1A476M-RD0	500	
	100	_	7343	D0	10.00	0.12	0.08	0.1	0.12	0.12	0.79	SYL-1A107M-RD0	500	
	150	_	7343	D0	15.00	0.15	0.1	0.13	0.15	0.12	0.79	SYL-1A157M-RD0	500	\sqcup
	1	CA	2012	P	0.50	0.09	0.06	0.072	0.09	5.0	0.06	SYL-1C105M-RP	3,000	
	2.2	CJ	2012	P	0.50	0.12	0.08	0.096	0.12	5.0	0.06	SYL-1C225M-RP	3,000	
	2.2	C225	3216L	A2	0.50	0.09	0.06	0.08	0.09	4.0	0.08	SYL-1C225M-RA2	3,000	
	3.3	C335	3216L	A2	0.50	0.09	0.06	0.08	0.09	3.0	0.09	SYL-1C335M-RA2	3,000	
	3.3	C335	3216	A	0.50	0.09	0.06	0.08	0.09	1.8	0.13	SYL-1C335M-RA	2,000	
	4.7	C475	3216	A	0.75	0.09	0.06	0.08	0.09	1.8	0.13	SYL-1C475M-RA	2,000	
16	4.7	_	3528	В	0.75	0.09	0.06	0.08	0.09	1.8	0.13	SYL-1C475M-RB	2,000	
	10	_	3528	В	1.60	0.09	0.06	0.08	0.09	1.0	0.17	SYL-1C106M-RB	2,000	
	10	_	6032	C	1.60	0.09	0.06	0.08	0.09	0.9	0.24	SYL-1C106M-RC	500	
	22		6032	C	3.52	0.09	0.06	0.08	0.09	0.4	0.35	SYL-1C226M-RC	500	
	33	_	6032	C	5.28	0.09	0.06	0.08	0.09	0.4	0.35	SYL-1C336M-RC	500	
	33	_	7343	D0	5.28	0.09	0.06	0.08	0.09	0.25	0.55	SYL-1C336M-RD0	500	
	47	_	7343	D0	7.52	0.09	0.06	0.08	0.09	0.2	0.61	SYL-1C476M-RD0	500	

Case size & $ESR(\Omega)$

Rated capacitance (µF)	4V	6.3V	10V	16V
1				P(5.0)
2.2			P(5.0)	P(5.0), A2(4.0)
3.3		P(3.0)	A2(3.0)	A2(3.0), A(1.8)
4.7		P(2.0), A2(2.0)	A2(2.0), A(2.0)	A(1.8), B(1.8)
10	P(1.2)	P(1.2), A2(1.2), A(1.2)	A2(1.5), A(1.0)	B(1.0), C(0.9)
22	A2(1.0)	A(0.8)	B(1.0)	C(0.4)
33	A2(1.0), A(0.8)	A(0.8), B(0.8)	B(0.8),C(0.375)	C(0.4), D0(0.25)
47	A(0.8), B(0.8)	B(1.0),C(0.4)	B(0.7),C(0.4), D0(0.3)	D0(0.2)
100	B(0.7), C(0.3)	B(0.7), C(0.25), D0(0.15)	D0(0.12)	
150			D0(0.12)	
220	D0(0.1)	D0(0.1)		
330	D0(0.1)			

TECHNICAL NOTE TANTALUM CHIP CAPACITORS (CHIPCON)



Structure of a tantalum chip capacitor

To manufacture a tantalum chip capacitor, metallic tantalum(Ta) powder is pressed and formed with a tantalum lead wire, and then sintered in a vacuum; by the electrochemical anodic oxidation, tantalum oxide film (Ta₂O₅) is formed on the fired sur-face; this oxide is used as the dielectric.

On top of the dielectric, a solid manganese dioxide layer(MnO₂) is formed as the electrolyte through the thermal decomposition of manganese nitrate.

To make an electrical connection on the manganese dioxide layer, a graphite layer and a conductive adhesive are used to fix a cathode lead.

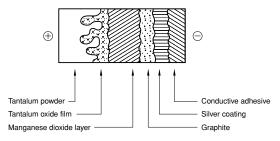


Fig.1 Diagrammatic sketch of a tantalum electrolytic capacitor

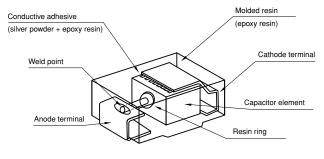


Fig.2 Structure of a tantalum chip capacitor

■ Working conditions and reliability (failure rate) of tantalum chip capacitors

Tantalum chip capacitors basically have high temperature resistance and stable electrical characteristics, and is expected to have a long life, because tantalum and tantalum oxidized films are extremely stable, and manganese dioxide serving as a solid electrolyte is also a stable inorganic solid.

On the other side, they tend to have a sudden failure because the tantalum oxidized films serving as an electrolyte are very thin and solid elements.

Consequently, the failure rate curve shows a gradual downturn from the beginning, different from a Bathtub shaped curve specific to the aluminum electrolytic capacitors.

More than 90% of tantalum chip capacitor failures are caused by increased leakage current or short circuits. Reliability is affected by various conditions for solid tantalum chip capacitors and environmental conditions. These capacitors are particularly affected by ambient temperatures, applied voltage(working voltage), and circuit resistance.

■Ambient temperature, applied voltage(working voltage), and reliability

Reliability (failure rate) of solid tantalum electrolytic capacitors is generally proportional to the powers of temperature and powers of voltage in natural logarithm. An estimated failure rate is expressed by the following formula.

$$\lambda = \lambda_0 \left(\frac{V}{V_0} \right) \cdot 2^{\left(\frac{T - T_0}{F} \right)}$$

 λ : Basic failure rate.

n: Factor for capacitor type. F: Factor for capacitor type.

T: Working temperature.

T₀: Upper category temperature.

V : Working voltage.

V₀: Rated voltage.

For solid tantalum electrolytic capacitors, it has been confirmed that n and F are 3 and 15 respectively on an experimental basis. This easy formula is illustrated in Fig.3.

In the figure;

Vertical lines

: Actual failure rate to failure rate λ_0 , which is the failure rate at T₀=85°C and V0=Rated voltage

Horizontal lines: Actual working temperature The parameter of each line [working voltage / rated voltage] shows the voltage reduction factor.

■Series circuit resistance and reliability

A resistance connected with a capacitor reduces the electrical load to the dielectric film of the capacitor. This occurs because it controls the charging and discharging current of the capacitor.

Namely, the greater the series resistance, the greater the electrical load reduction to the dielectric film.

Thus, resulting in higher reliability.

The relationship between a series resistance and reliability (failure rate) is shown in Fig.4.

In the figure;

Vertical lines : Ratio when the failure for $3\Omega/V$ is

assumed to be 1.

Horizontal lines: Resistance value per volt of applied voltage.



LNA® TANTALUM CHIP CAPACITORS (CHIPCON) TECHNICAL NOTE

Estimation of the failure rate under actual working conditions

Reliability of electronic parts is generally shown by the failure rate:

Number of failure parts Failure Rate= Working hours x Number of components in operation x 100 . (%/1000 hours)

Note: The unit of working hours to be 1000 hours.

Failure rate setting: For our products, failure rates are set under the following conditions.

Standard conditions for setting the failure rates						
Applied voltage	Rated Voltage					
Working temperature	85°C					
Circuit	3Ω /V					

(A) Failure the setting 1%/1000 hours(60% reliability level)

Failure rate of actual working time: A prediction of reliability in actual working time can be calculated from coefficients in Fig.3 and Fig.4 and the calculation formula.

Estimated failure rate in actual working time(%/1000 hours)=AxBxC

A= Set failure rate

B= Working voltage; Reduction index of temperature (refer to Fig.3)

C= Circuit resistance coefficient(refer to Fig.4)

Example of calculation: A Type SK 16V10µF capacitor with a capacitance tolerance of ±20% is used under the following conditions:

Working conditions: Applied voltage: 9.6V;

Working temperature: 50°C; 0.043

from Fig.3;

Circuit resistance: 2Ω / V; 1.7

from Fig.4;

Estimated failure rate: 1x 0.043 x1.7=0.073(% / 1000

hours).

Mean time of failure: If the reliability function (Rt) abides by the exponential distribution, the failure rate will be constant in any section and the MTTF (Mean Time to Failures) will be the inverse number of the failure rate,

$$MTTF = \frac{1}{\text{Mean Failure Rate}}$$

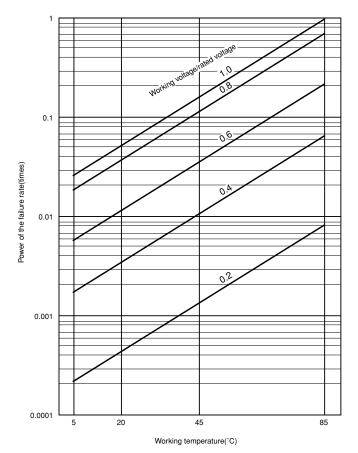


Fig.3 Relationship between the working temperature, applied voltage, and the failure rate.

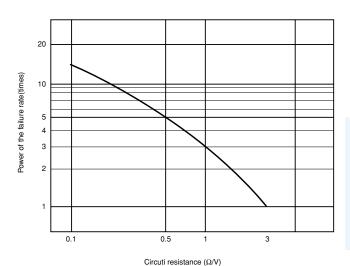


Fig.4 Relationship between the series circuit resistance and failure rate.

TECHNICAL NOTE TANTALUM CHIP CAPACITORS (CHIPCON)



Ripple capability

The ripple current capability of tantalum solid electrolytic capacitor takes into consideration the equivalent series resistance (ESR) and the effect of heat generation due to

Ripple current generates heat due to the internal energy loss of the capacitor.

The allowable ripple current is decided by the heat generated due the internal resistance of the capacitor and the balance of thermal discharge of the mold resin, lead frame, and the like. The allowable ripple current is also presumed to be affected by capacitance, frequency, ambient temperature, case size, and the like.

Heat value, P, generated by ripple current due to the internal loss of the capacitor is expressed as follows.

V: Ripple voltage (Vrms)

Z: Impedance (Ω)

Temperature rise due to heat generation is expressed as follows;

$$\Delta T = \frac{P}{A \cdot H}$$
 ②

ΔT: Temperature rise due to heat generation (deg)

A: Surface area (cm²)

H: Radiation coefficient (W/cm²·deg)

Set an allowable ripple current and allowable voltage so that ΔT should be 5deg or under.

In general, since the tantalum solid electrolytic capacitor does not often carry large low-frequency current for smoothing power supply or the like, allowable ripple voltage and current are set. This takes into consideration the effect of voltage in the low-frequency domain and that of current in the highfrequency domain.

Allowable ripple voltage and allowable ripple current in low-frequency domain

From Formula (1)

$$Vmax=Z \sqrt{\frac{Pmax}{R}} \cdots \cdot 3$$

Pmax: Maximum generated heat value Vmax: Maximum allowable ripple voltage

Where (1) The sum of the DC bias voltage and the max. AC applied ripple voltage (V max) can not exceed the rated

> (2) The sum of the DC bias voltage and the min. AC applied ripple voltage can not be a negative voltage (reverse voltage).

The maximum allowable ripple current is obtained by dividing

Now, since the inductance component can be neglected within the range of frequency we are facing.

$$Z = \sqrt{\left(\frac{1}{\omega C}\right)^2 + \left(\frac{\tan \delta}{\omega C}\right)^2}$$
$$= \left(\frac{1}{2\pi f C}\right) \sqrt{1 + (\tan \delta)^2} \cdots (8)$$

Since $tan\delta$ is as small as 0.02 to 0.04 within the low-frequency range of 500Hz or under, it is insignificant when compares to 1, therefore can be ignored.

From formula 8

$$Z = \frac{1}{2\pi fC} \cdots 9$$

Substituting formula 9 for formula 4

Expressing the capacity in µF.

Allowable ripple current in high-frequency domain

In a domain of 500Hz to several hundred kHz, since considerably large current flows through dielectric film due to low impedance, heat generated by ripple current must be taken into consideration.

From Formula(1)

Irms =
$$\sqrt{\frac{Pmax}{R}} \cdots \cdots (12)$$

The allowable maximum heat values generated at 20°C have been decided by case size as follows.

Table 1. Allowable maximum heat values by case size

Case Size	Allowable maximum heat values Pmax(W)			
	SPY	SYF,SKY,SYL		
J	_	0.020		
Р	0.025	0.022		
A2	_	0.026		
Α	_	0.030		
В	0.085	0.030		
С	-	0.050		
D0	_	0.075		

Where, R is ESR at a required frequency. Use $(\bar{\chi}+3\sigma)$ of actual average value for safety. Make a calculation using ESR values shown in the standard model table.

Furthermore, multiply the value by a temperature compensation coefficient taking heat radiation according to ambient temperature into consideration.

Table 2. Temperature compensation coefficient

Ambient temperature	Coefficient		
Ambient temperature	SPY	SYF,SKY,SYL	
20°C	1.0	1.0	
50°C	-	0.7	
85°C	0.9	0.5	
105°C	0.4	_	



LNA® TANTALUM CHIP CAPACITORS (CHIPCON) TECHNICAL NOTE

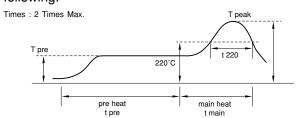
Soldering

- 1. It is recommended that chip type parts be soldered within the following conditions. Soldering should be carried out in a short time and at low temperature as much as possible.
- (1) Solder dipping method

Solder temperature: Not more than 260°C : Not more than 5 s Dipping time

(2) Reflow method

According to the reflow profile conditions shown in the following.



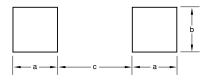
		SPY	SYF,SKY,SYL
T pre	Preheating temperature	160~180°C	160~180°C
T peak	Peak temperature	240°C (Max.)	250°C (Max.)
t pre	Preheating time	100 s (Max.)	100 s (Max.)
t main	Main heating time	50 s (Max.)	50 s (Max.)
t 220	Time for which solder temperature exceeds 220°C	20 s (Max.)	40 s (Max.)
t peak	Time at peak temperature	5 s (Max.)	3 s (Max.)

The peak temperature of soldering recommends from 235 to 250°C.

Though upward heating, such as that by a hot plate, does not cause any problem, downward heating by an atmospheric furnace by means of infrared rays could raise the temperature of capacitors to temperatures higher than that of the substrate surface. Therefore, care must be taken.

- 2. Use preliminary heating as far as possible, and relieve the temperature gradient for soldering.
- 3. Use resin flux.
- 4. For the reflow method, if the land area is too big in comparison with the capacitor terminal area, the capacitor is likely to slip or turn over. Therefore, caution must be taken.
- 5. For the solder bathing method, since high density packaging sometimes adversely affects solderability, take measures, such as removing air, into consideration.

6. Recommended pad pattern and size



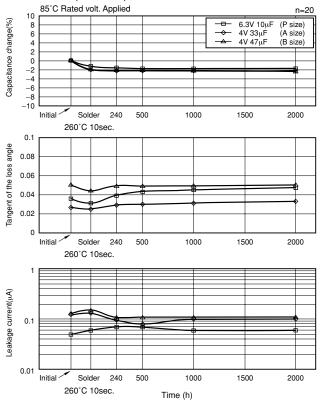
Unit: mm

Case	a	a	b	С	
Size	Solder Dipping Reflow		D		
J	-	0.90	1.0	0.7	
Р	2.2	1.05	1.2	0.5	
A2, A	2.9	1.35	1.5	1.1	
В	3.0	1.35	2.7	1.4	
С	4.1	2.0	2.7	2.9	
D0	5.2	2.05	2.9	4.1	

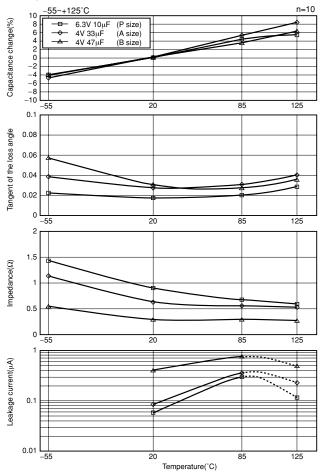
TECHNICAL NOTE TANTALUM CHIP CAPACITORS (CHIPCON) ELNA

Reference data

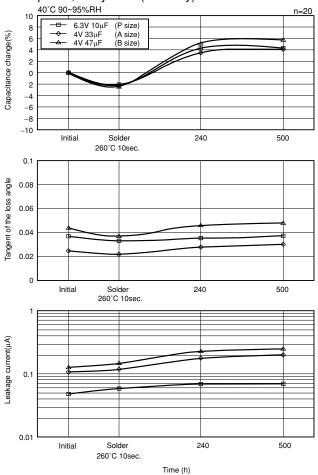
■ Endurance (Load life)



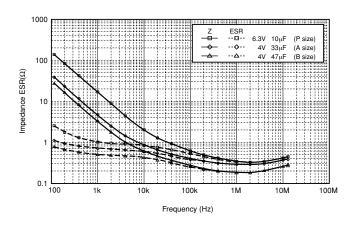
■ Temperature characteristics



■ Damp hear, stady state (Humidity)



■ Frequency characteristics



Notice: The measurement values are not guaranteed values, but measurements.

Data of leakage current at 125°C have been measured at category voltage.

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